Search Notes

Application/Control	No.

Applicant(s)/Patent	t unaer
Reexamination	

10/575,723

Louis K. Huynh

KONNO ET AL.

Art Unit

10/373,72 Examiner

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SEARCHED			
Class	Subclass	Date	Examiner
53	373.7 374.3 374.5 374.6 375.9	9/24/2007	LH
53	550 551 552	9/24/2007	LH
156	367	9/24/2007	LH
219	633	9/24/2007	LH

INTERFERENCE SEARCHED			
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